



## **Schedule of Scope to Certificate of Conformity Approved Process**

**IECQ Certificate No.: IECQ-P JQAJP 13.0009**

**CB Certificate No.: JQAQ 0014-001-M**

**Schedule Number: IECQ-P JQAJP 13.0009-S    Rev No.:3    Revision Date:2018/02/16    Page 1 of 1**

In respect of standards and specifications:

IEC 60747-1:2006

Semiconductor devices  
- Part 1: General

IEC 60748-1:2002

Semiconductor devices - Integrated circuits  
- Part 1: General

IEC 60748-20:1988

Semiconductor devices. Integrated circuits  
- Part 20: Generic specification for film integrated circuits and  
hybrid film integrated circuits

ISO 9001:2015

Quality management systems - Requirements

Component:

Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

Scope:

The design, manufacture and test of Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

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